

Notice of References Cited	Application/Control No. 10/639,612		Applicant(s)/Patent Under Reexamination WILENSKY, GREGG D.	
	Examiner MAX SHIKHMAN		Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,204,858 B1	03-2001	Gupta, Naresh C.	345/600
*	B	US-2002/0136452 A1	09-2002	Schroder, Michael	382/165
*	C	US-2002/0126893 A1	09-2002	Held et al.	382/167
*	D	US-2002/0181746 A1	12-2002	Schwartz et al.	382/117
*	E	US-2003/0007687 A1	01-2003	Nesterov et al.	382/167
*	F	US-2003/0068084 A1	04-2003	Kinjo et al.	382/164
*	G	US-2004/0037460 A1	02-2004	Luo et al.	382/165
*	H	US-6,721,446 B1	04-2004	Wilensky et al.	382/162
*	I	US-7,042,505 B1	05-2006	DeLuca, Michael J.	348/241
*	J	US-7,116,820 B2	10-2006	Luo et al.	382/167
*	K	US-7,127,108 B2	10-2006	Kinjo et al.	382/203
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.